# WP5401

## USB Type-C Port Protector: Short-to-VBUS Overvoltage and IEC ESD Protection

### ● 1.General Description

The WP5401 is a USB Type-C port protection chip that provides 20-V Short-to-VBUS overvoltage and IEC ESD protection.

By integrating low on-resistance power switch and low capacitance TVS, the WP5401 protects USB Type-C ports CC，SBU that undergoing overvoltage and IEC 61000-4-2 system level ESD without interfering with normal operation.
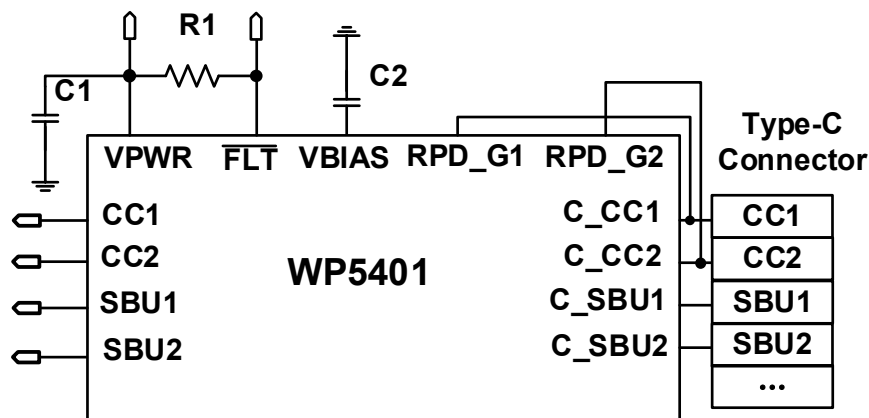
### ● 2. Features

- Short to VBUS Overvoltage Protection for CC1, CC2, SBU1 and SBU2
- IEC 61000-4-2 ESD Protection for CC1, CC2, SBU1, SBU2
- Fast OVP response for CCX and SBUX
- CC Dead Battery Resistors integrated for handling dead battery use case in mobile devices
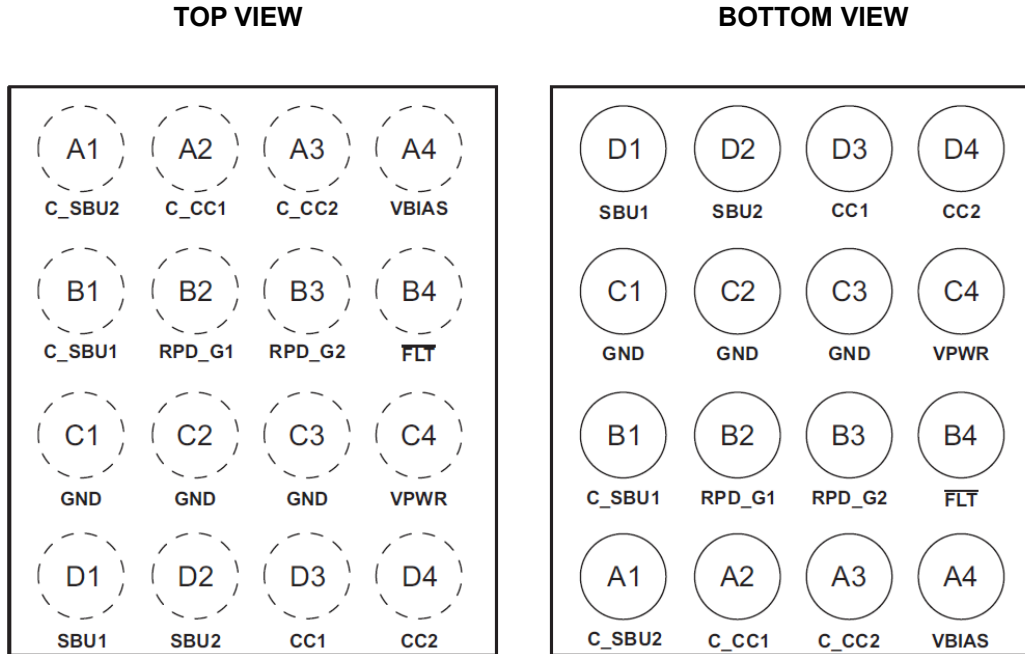- Package: WLCSP16

### ● 3. Applications

- Laptop PC
- Tablets
- Smart phones
- Monitors and TVS
- Docking Stations

### ● 4. Typical Application

## ● 5. Pin Configuration

**TOP VIEW**

**BOTTOM VIEW**

| | | | |
|---|---|---|---|
| A1 C_SBU2 | A2 C_CC1 | A3 C_CC2 | A4 VBIAS |
| B1 C_SBU1 | B2 RPD_G1 | B3 RPD_G2 | B4 $\overline{FLT}$ |
| C1 GND | C2 GND | C3 GND | C4 VPWR |
| D1 SBU1 | D2 SBU2 | D3 CC1 | D4 CC2 |

| | | | |
|---|---|---|---|
| D1 SBU1 | D2 SBU2 | D3 CC1 | D4 CC2 |
| C1 GND | C2 GND | C3 GND | C4 VPWR |
| B1 C_SBU1 | B2 RPD_G1 | B3 RPD_G2 | B4 $\overline{FLT}$ |
| A1 C_SBU2 | A2 C_CC1 | A3 C_CC2 | A4 VBIAS |

## ● 6. Pin Description

| PIN NUMBER | PIN NAME | I/O | PIN FUNCTIONS |
|---|---|---|---|
| A1 | C_SBU2 | I/O | Connector side of the SBU2 OVP FET. Connect to either SBU pin of the USB Type-C connector. |
| A2 | C_CC1 | I/O | Connector side of the CC1 OVP FET. Connect to either CC pin of the USB Type-C connector. |
| A3 | C_CC2 | I/O | Connector side of the CC2 OVP FET. Connect to either CC pin of the USB Type-C connector. |
| A4 | VBIAS | Power | Pin for ESD support capacitor. Place a 0.1-µF capacitor on this pin to ground. |
| B1 | C_SBU1 | I/O | Connector side of the SBU1 OVP FET. Connect to either SBU pin of the USB Type-C connector. |
| B2 | RPD_G1 | I/O | Short to C_CC1 if dead battery resistors are needed. If dead battery resistors are not needed, short pin to GND. |
| B3 | RPD_G2 | I/O | Short to C_CC2 if dead battery resistors are needed. If dead battery resistors are not needed, short pin to GND. |
| B4 | $\overline{FLT}$ | O | Open drain for fault reporting. Under over temperature & over voltage conditions, pull low. Otherwise stay high-Z. Connect to VPWR by external resistor. |
| C1, C2, C3 | GND | GND | Ground. |

| PIN NUMBER | PIN NAME | I/O | PIN FUNCTIONS |
|---|---|---|---|
| C4 | VPWR | Power | 2.7V - 4.5V power supply. |
| D1 | SBU1 | I/O | System side of the SBU1 OVP FET. Connect to either SBU pin of the SBU MUX. |
| D2 | SBU2 | I/O | System side of the SBU2 OVP FET. Connect to either SBU pin of the SBU MUX. |
| D3 | CC1 | I/O | System side of the CC1 OVP FET. Connect to either CC pin of the CC/PD controller. |
| D4 | CC2 | I/O | System side of the CC2 OVP FET. Connect to either CC pin of the CC/PD controller. |

## ● 7. Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)[1]

| PARAMETER | | RATING | UNIT |
|---|---|---|---|
| Input Voltage | VPWR | -0.3 to 5 | V |
| | RPD_G1, RPD_G2 | -0.3 to 24 | V |
| Output Voltage | $\overline{FLT}$ | -0.3 to 6 | V |
| | VBIAS | -0.3 to 24 | V |
| I/O Voltage | CC1, CC2, SBU1, SBU2 | -0.3 to 6 | V |
| | C_CC1, C_CC2, C_SBU1, C_SBU2 | -0.3 to 24 | V |
| Output Current | CC1, CC2 | 1.25 | A |
| Operating Free Air Temperature | | -40 to 85 | °C |
| Storage Temperature | | -85 to 150 | °C |

(1)    Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## ● 8. ESD Ratings—JEDEC Specification

| PARAMETER | | VALUE | UNIT |
|---|---|---|---|
| Electrostatic Discharge | Human-Body Model (HBM), Per ANSI/ESDA/JEDEC JS-001[1] | ±4000 | V |

(1)    JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±2000 V may actually have higher performance.

## ● 9. ESD Ratings—IEC Specification

| PARAMETER | | | VALUE | UNIT |
|---|---|---|---|---|
| Electrostatic Discharge | IEC 61000-4-2, C_SBU1, C_SBU2 | Contact Discharge | ±6000 | V |
| | | Air-gap Discharge | ±15000 | |
| | IEC 61000-4-2, C_CC1, C_CC2 | Contact Discharge | ±3500 | |
| | | Air-gap Discharge | ±15000 | |
| Lightning and Surge | IEC 61000-4-5, C_CC1, C_CC2, C_SBU1, C_SBU2 | | ±35 | V |

## ● 10. Recommended Operating Conditions

(Over operating free-air temperature range, unless otherwise noted)

| SYMBOL | PARAMETER | | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $V_{IN}$ | Input Voltage | VPWR | 2.7 | 3.3 | 4.5 | V |
| | | RPD_G1, RPD_G2 | 0 | | 5.5 | V |
| $V_{OUT}$ | $\overline{FLT}$ Pull-up Resistor Power Aail | | 2.7 | | 5.5 | V |
| $V_{IO}$ | I/O Voltage | CC1, CC2, C_CC1, C_CC2 | 0 | | 5.5 | V |
| | | SBU1, SBU2, C_SBU1, C_SBU2 | 0 | | 4.3 | V |
| $I_{VCONN}$ | $V_{CONN}$ Current | Current flowing into CC1/2 and flowing out of C_CC1/2, $V_{CCX} - V_{C\_CCX} \leq 250$ mV | | | 600 | mA |
| $I_{VCONN}$ | $V_{CONN}$ Current | Current flowing into CC1/2 and flowing out of C_CC1/2, $T_J \leq 105°C$ | | | 1.25 | A |
| | External Components[1] | $\overline{FLT}$ Pull-up Resistance | 1.7 | | 300 | kΩ |
| | | VBIAS Capacitance[2] | | 0.1 | | µF |
| | | VPWR Capacitance | 0.3 | 1 | | µF |

(1)   For recommended values for capacitors and resistors, the typical values assume a component placed on the board near the pin. Minimum and maximum values listed are inclusive of manufacturing tolerances, voltage derating, board capacitance, and temperature variation. The effective value presented must be within the minimum and maximums listed in the table.

(2)   The VBIAS pin requires a minimum 35-$V_{DC}$ rated capacitor. A 50-$V_{DC}$ rated capacitor is recommended to reduce capacitance derating. See the VBIAS Capacitor Selection section for more information on selecting the VBIAS capacitor.

## ● 9. Electrical Characteristics

(Over operating free-air temperature range, unless otherwise noted)

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| **CC OVP Switches** | | | | | | |
| $R_{ON}$ | On resistance of CC OVP FETs, $T_J \leq 85\,^{\circ}C$ | CCX = 5.5 V | | 300 | 600 | mΩ |
| $R_{ONFLAT}$ | On resistance flatness | Sweep CCX voltage between 0V and1.2V | | | 5 | mΩ |
| $C_{ON\_CC}$ | Equivalent on capacitance | Capacitance from C_CCX or CCX to GND. $V_{C\_CCX/VCCX} = 0$ V to 1.2 V, f = 400 kHz | 30 | 74 | 90 | pF |
| $R_{D\_DB}$ | Dead battery pull-down resistance (only present when device is unpowered). Effective resistance of RD and FET in series | $V_{C\_CCX} = 2.6$ V | 4.1 | 5.1 | 6.1 | KΩ |
| $V_{TH\_DB}$ | Threshold voltage of the pulldown FET in series with RD during dead battery | $I_{CC} = 80$ µA | 0.5 | 0.9 | 1.2 | V |
| $V_{OVPCC}$ | OVP threshold on CC pins | Place 5.5 V on C_CC$_X$. Step up C_CC$_X$ until the $\overline{FLT}$ pin is asserted | 5.75 | 6 | 6.2 | V |
| $V_{OVPCC\_HYS}$ | Hysteresis on CC OVP | Place 6.5 V on C_CC$_X$. Step down the voltage on C_CC$_X$ until the $\overline{FLT}$ pin is deasserted. Measure difference between rising and falling OVP threshold for CC | | 50 | | mV |
| $BW_{ON}$ | On bandwidth single ended (–3 dB) | Measure the –3-dB bandwidth from C_CC$_X$ to CCX. Single ended measurement, 50Ω system $V_{CM} = 0.1$ V to 1.2 V | | 100 | | MHz |
| $V_{STBUS\_CC}$ | Short-to-VBUS tolerance on the CC pins | Hot-Plug C_CC$_X$ with a 1meter USB Type C Cable, place a 30-Ω load on CC$_X$ | | | 24 | V |

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $V_{STBUS\_CC\_CLAMP}$ | Short-to-VBUS system-side clamping voltage on the CC pins (CCX) | Hot-Plug C_CCX with a 1-meter USB Type C Cable. Hot-Plug voltage C_CCX = 24 V. VPWR = 3.3 V. Place a 30Ω load on CCX | | 6 | | V |
| **SBU OVP Switches** | | | | | | |
| $R_{ON}$ | On resistance of SBU OVP FETs | SBUX = 3.6 V, −40°C ≤ $T_J$ ≤ +85°C | | 3.5 | 6.5 | Ω |
| $R_{ONFLAT}$ | On resistance flatness | Sweep SBUX voltage between 0 V and 3.6 V. −40°C ≤ $T_J$ ≤ +85°C | | 1 | 1.5 | Ω |
| $C_{ON\_SBU}$ | Equivalent on capacitance | Capacitance from SBUX or C_SBUX to GND. Measure at $V_{C\_SBUX}/V_{SBUX}$ = 0.3 V to 3.6 V | | 9 | | pF |
| $V_{OVPSBU}$ | OVP threshold on SBU pins | Place 3.6 V on C_SBUX. Step up C_SBUX until the $\overline{FLT}$ pin is asserted | 4.3 | 4.5 | 4.75 | V |
| $V_{OVPSBU\_HYS}$ | Hysteresis on SBU OVP | Place 5 V on C_CCX. Step down the voltage on C_CCX until the $\overline{FLT}$ pin is deasserted. Measure difference between rising and falling OVP threshold for C_SBUX | | 60 | | mV |
| $BW_{ON}$ | On bandwidth single ended (−3 dB) | Measure the −3-dB bandwidth from C_SBUX to SBUX. Single ended measurement, 50-Ω system. $V_{CM}$ = 0.1 V to 3.6 V | | 1000 | | MHz |
| $X_{TALK}$ | Crosstalk | Measure crosstalk at f = 1 MHz from SBU1 to C_SBU2 or SBU2 to C_SBU1. $V_{CM1}$ = 3.6 V, $V_{CM2}$=0.3V. Be sure to terminate open sides to 50 Ω | | -80 | | dB |
| $V_{STBUS\_SBU}$ | Short-to-VBUS tolerance on the SBU pins | Hot-Plug C_SBUX with a 1-meter USB Type C Cable. Put a 40Ω resistor to GND on SBUX | | | 24 | V |

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $V_{STBUS\_SBU\_CLAMP}$ | Short-to-VBUS system-side clamping voltage on the SBU pins (SBUX) | Hot-Plug C_SBUX with a 1-meter USB Type C Cable. Hot-Plug voltage $V_{C\_SBUX}$ = 24 V. $V_{PWR}$ = 3.3 V. Put a 40Ω resistor to GND on SBUX | | 4.5 | | V |
| **Power Supply and Leakage Currents** | | | | | | |
| $V_{PWR\_UVLO}$ | VPWR under voltage lockout | Place 1 V on VPWR and raise voltage until SBU or CC FETs turn on | 2.1 | 2.3 | 2.5 | V |
| $V_{PWR\_UVLO\_HYS}$ | VPWR UVLO hysteresis | Place 3 V on VPWR and lower voltage until SBU or CC FETs turnoff; measure difference between rising and falling UVLO to calculate hysteresis | | 100 | | mV |
| $I_{VPWR}$ | VPWR supply current | $V_{PWR}$ = 3.3 V (Typical), $V_{PWR}$ = 3.6 V (Maximum). $-40°C \le T_J \le +85°C$. | | 70 | 120 | µA |
| $I_{CC\_LEAK}$ | Leakage current for CC pins when device is powered | $V_{PWR}$ = 3.3 V, $V_{C\_CCX}$ = 3.6 V, CCX pins are floating, measure leakage into C_CCX pins. Result must be same if CCX side is biased and C_CCX is left floating. | | | 5 | µA |
| $I_{SBU\_LEAK}$ | Leakage current for SBU pins when device is powered | $V_{PWR}$ = 3.3 V, $V_{C\_SBUX}$ = 3.6V, SBUX pins are floating, measure leakage into C_SBUX pins. Result must be same if SBUX side is biased and C_SBUX is left floating. $-40°C \le T_J \le 85°C$. | | | 3 | µA |
| $I_{C\_CC\_LEAK\_OVP}$ | Leakage current for CC pins when device is in OVP | $V_{PWR}$ = 0 V or 3.3 V, $V_{C\_CCX}$ = 24V, CCX pins are set to 0 V, Measure leakage into C_CCX pins | | | 200 | µA |

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $I_{C\_SBU\_LEAK\_OVP}$ | Leakage current for SBU pins when device is in OVP | $V_{PWR}$ = 0 V or 3.3 V, $V_{C\_SBUX}$ = 24 V, SBUX pins are set to 0 V, measure leakage into C_SBUX pins | | | 200 | µA |
| $I_{CC\_LEAK\_OVP}$ | Leakage current for CC pins when device is in OVP | $V_{PWR}$ = 0 V or 3.3 V, $V_{C\_CCX}$ = 24 V, CCX pins are set to 0 V, measure leakage out of CCX pins | | | 30 | µA |
| $I_{SBU\_LEAK\_OVP}$ | Leakage current for SBU pins when device is in OVP | $V_{PWR}$ = 0 V or 3.3 V, $V_{C\_SBUX}$ = 24 V, SBUX pins are set to 0 V, measure leakage out of SBUX pins | –1 | | 1 | µA |
| $I_{DX\_LEAK}$ | Leakage current for Dx pins | $V_{DX}$ = 3.6 V, measure leakage into Dx pins | | | 1 | µA |

## $\overline{FLT}$ Pin

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $V_{OL}$ | Low-level output voltage | $I_{OL}$ = 3 mA. Measure the voltage at the FLT pin | | | 0.4 | V |

## Over Temperature Protection

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $T_{SD\_RISING}$ | The rising over-temperature protection shutdown threshold | | | 170 | | °C |
| $T_{SD\_FALLING}$ | The falling over-temperature protection shutdown threshold | | | 135 | | °C |
| $T_{SD\_HYST}$ | The over-temperature protection shutdown threshold hysteresis | | | 35 | | °C |

## Power-On and Off Timings

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $t_{ON}$ | Time from crossing rising VPWR UVLO until CC and SBU OVP FETs are on | | | | 3.5 | ms |
| $d_{VPWR\_OFF/dt}$ | Minimum slew rate allowed to guarantee CC and SBU FETs turnoff during a power off | | –0.5 | | | V/µs |

## Over Voltage Protection

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|---|
| $t_{OVP\_RESPONSE\_CC}$ | OVP response time on the CC pins. Time from OVP asserted until OVP FETs turnoff | | | 80 | | ns |
| $t_{OVP\_RESPONSE\_SBU}$ | OVP response time on the SBU pins. Time from OVP asserted until OVP FETs turnoff | | | 130 | | ns |

| SYMBOL | PARAMETER | MIN | TYP. | MAX | UNIT |
|---|---|---|---|---|---|
| $t_{OVP\_RECOVERY\_CC\_1}$ | OVP recovery time on the CC pins. Once an OVP has occurred, the minimum time duration until the CC FETs turn back on. OVP must be removed for CC FETs to turn back on | 21 | 33 | 39 | ms |
| $t_{OVP\_RECOVERY\_SBU\_1}$ | OVP recovery time on the SBU pins. Once an OVP has occurred, the minimum time duration until the SBU FETs turn back on. OVP must be removed for SBU FETs to turn back on | 21 | 32 | 39 | ms |
| $t_{OVP\_RECOVERY\_CC\_2}$ | OVP recovery time on the CC pins. Time from OVP removal until CC FET turns back on, if device has been in OVP > 40 ms | | 0.1 | | ms |
| $t_{OVP\_RECOVERY\_SBU\_2}$ | OVP recovery time on the SBU pins. Time from OVP removal until SBU FET turns back on, if device has been in OVP > 40 ms | | 0.1 | | ms |
| $t_{OVP\_FLT\_ASSETION}$ | Time from OVP asserted to $\overline{FLT}$ assertion | | 12 | | μs |
| $t_{OVP\_FLT\_DEASSERTION}$ | Time from CC FET turn on after an OVP to $\overline{FLT}$ Deassertion | | 5 | | ms |

● **10. Typical Performance Characteristics**

($V_{PWR}$ = 3.3V, $T_A$ = 25°C, $C_1$ = 1μF, $C_2$ = 0.1μF, $R_1$ = 100kΩ, unless otherwise noted)
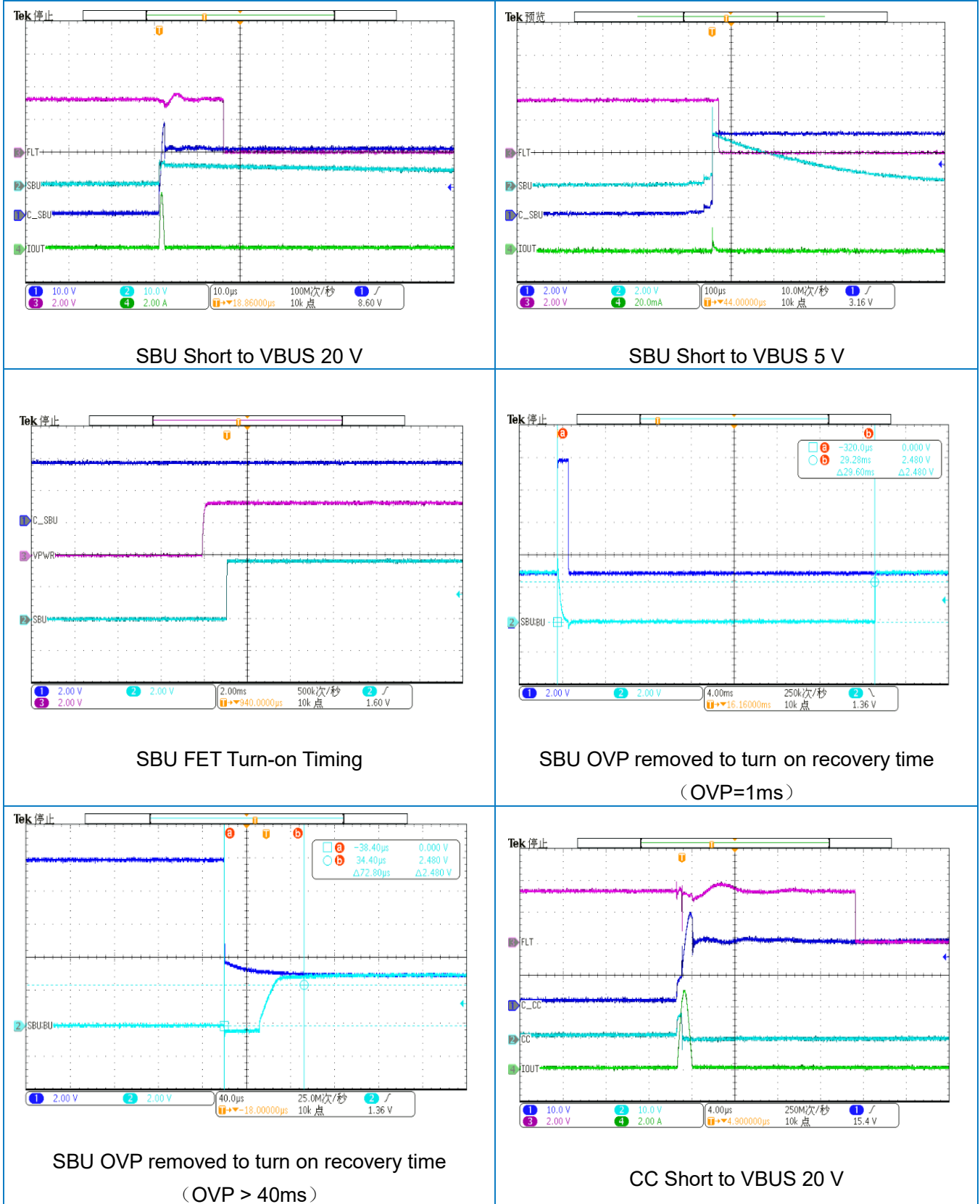


SBU Short to VBUS 20 V



SBU Short to VBUS 5 V



SBU FET Turn-on Timing



SBU OVP removed to turn on recovery time
（OVP=1ms）



SBU OVP removed to turn on recovery time
（OVP > 40ms）
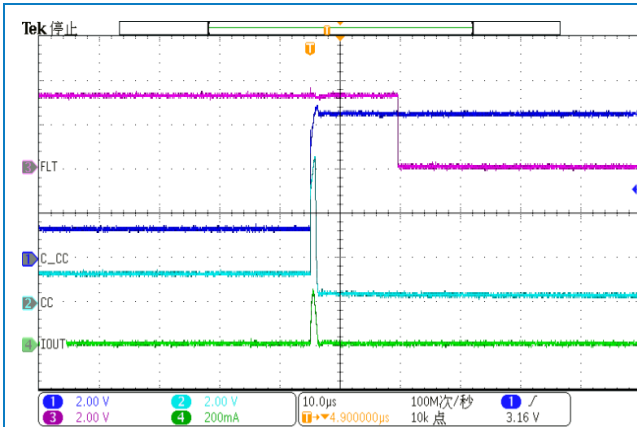


CC Short to VBUS 20 V

CC Short to VBUS 6.5 V
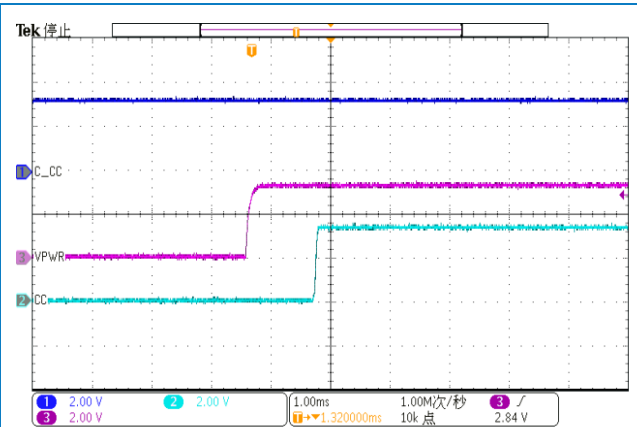


CC FET Turn-on Timing
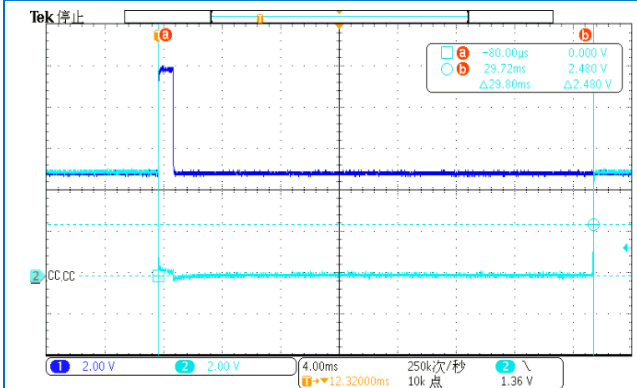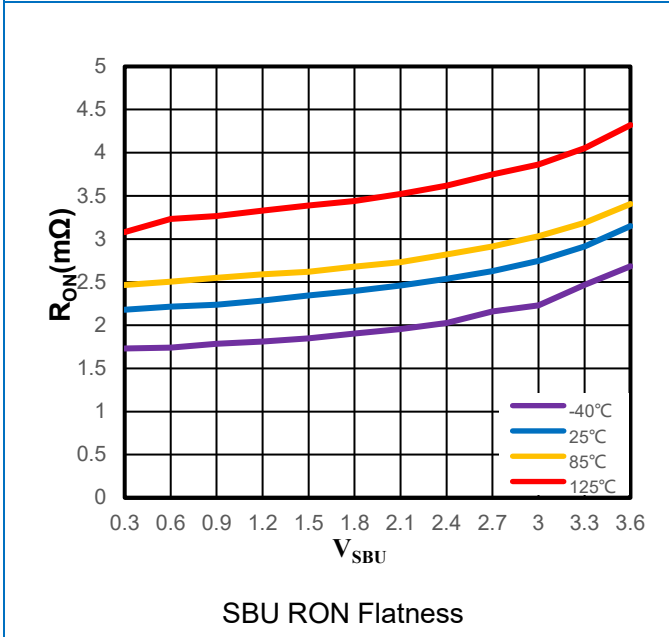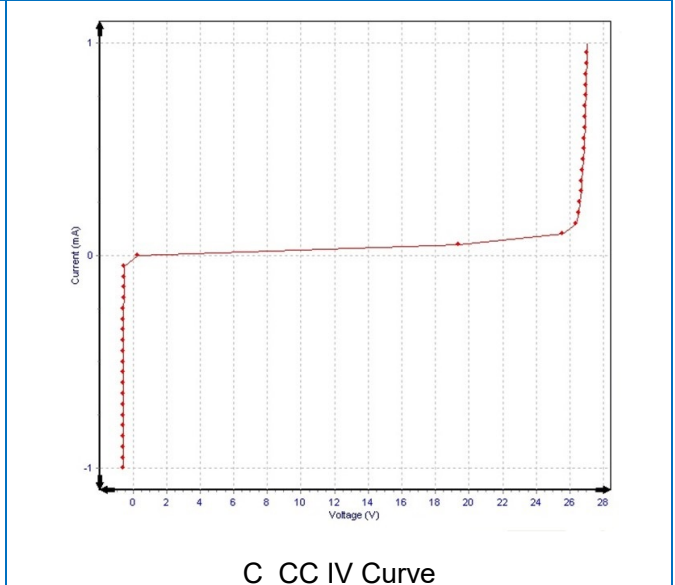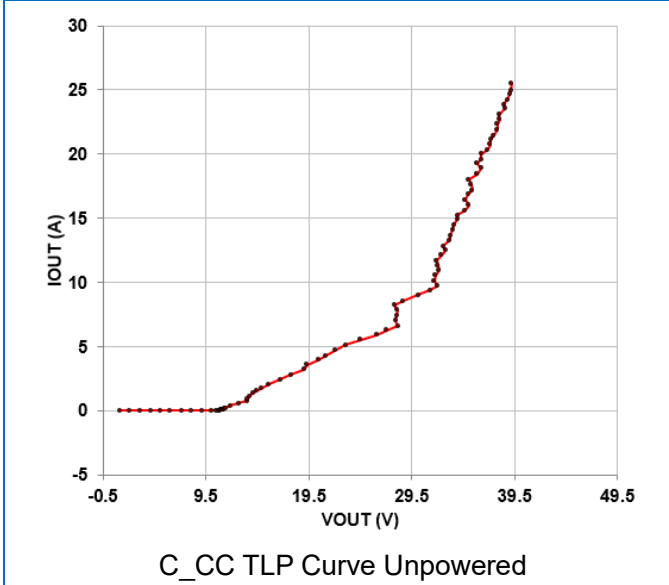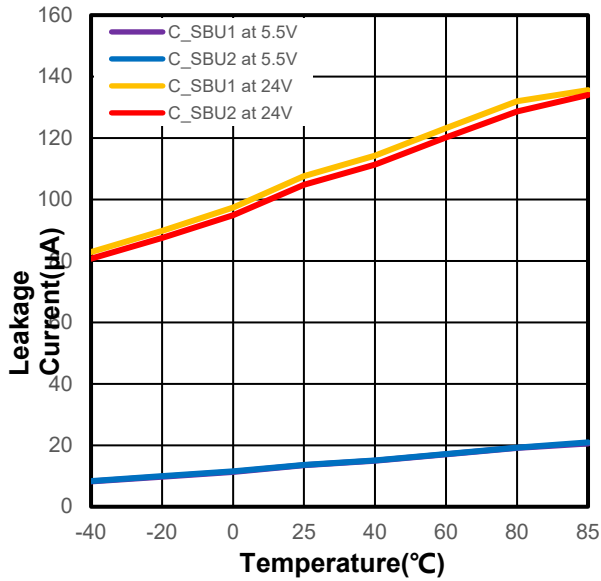


CC OVP removed to turn on recovery time

（OVP =1ms）
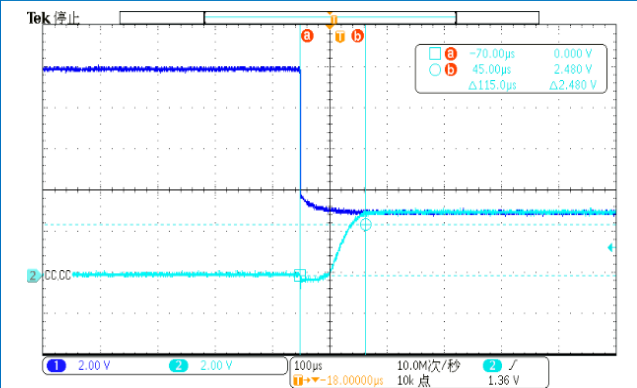


CC OVP removed to turn on recovery time

（OVP > 40 ms）
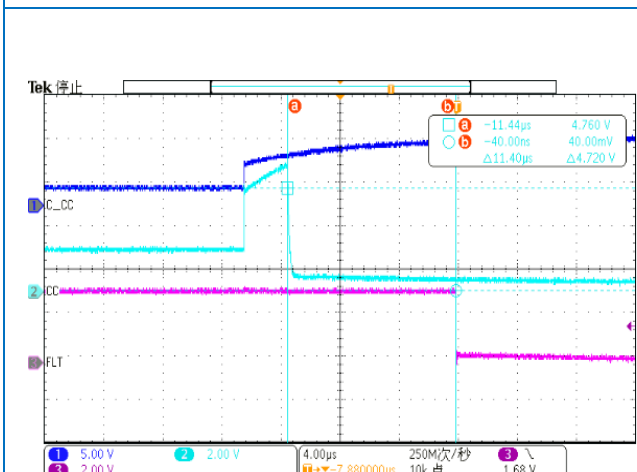


Time from OVP asserted to FLT assertion



Time from CC FET turn on after an OVP to $\overline{FLT}$ deassertion

C_SBU TLP Curve Unpowered



SBU IV Curve



C_CC TLP Curve Unpowered



C_CC IV Curve
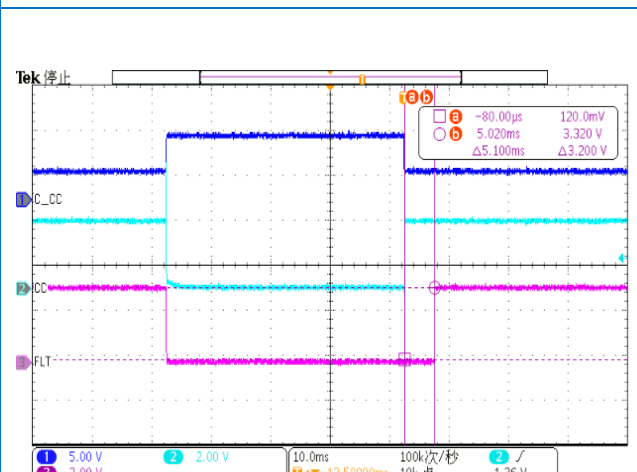


SBU RON Flatness



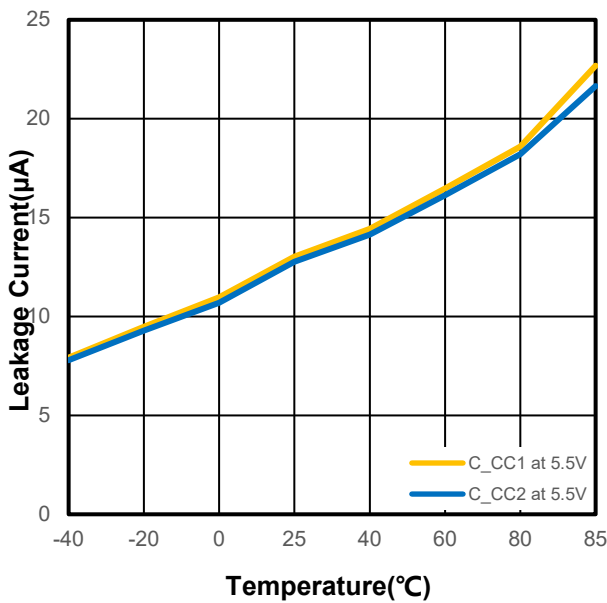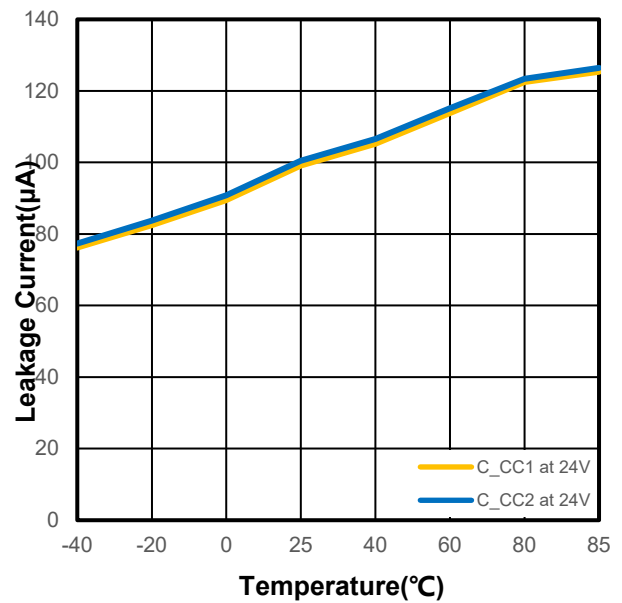SBU Path Leakage Current vs Ambient Temperature at 3.6 V
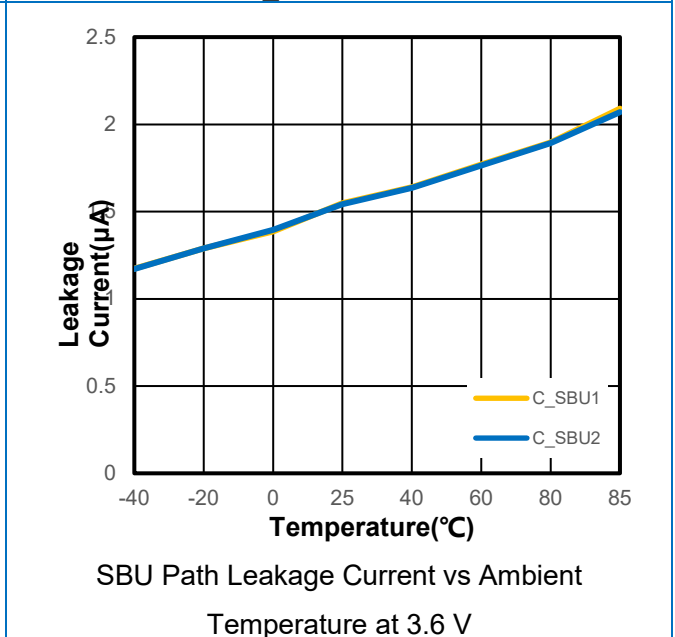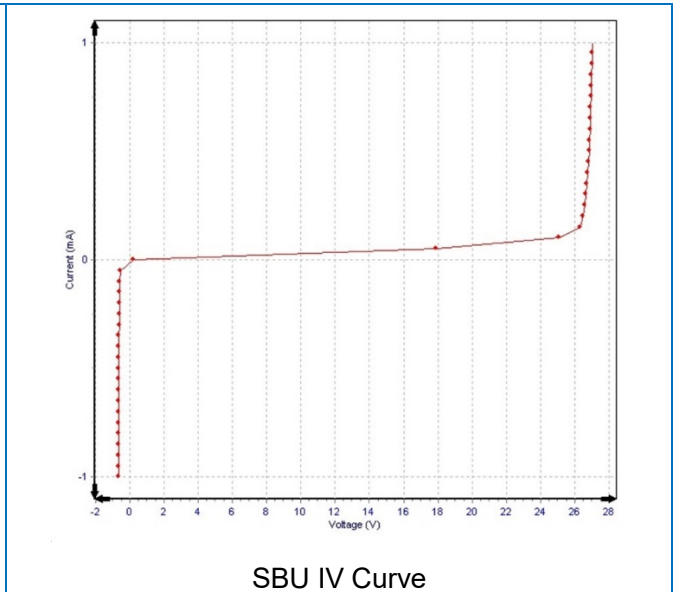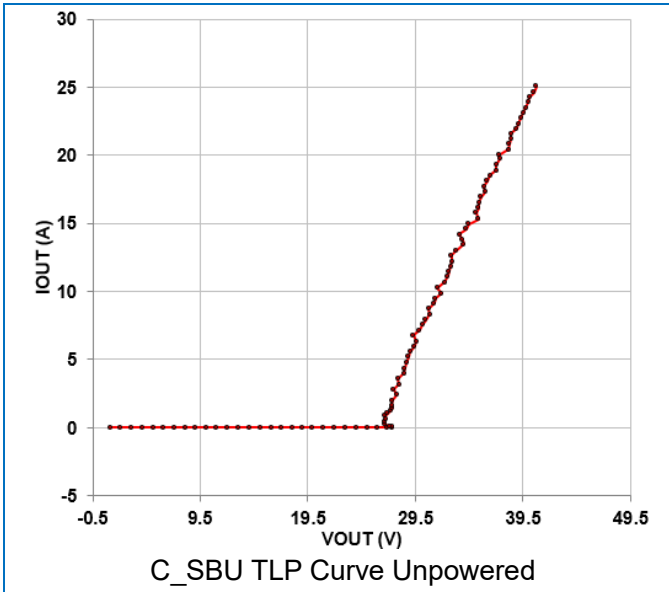
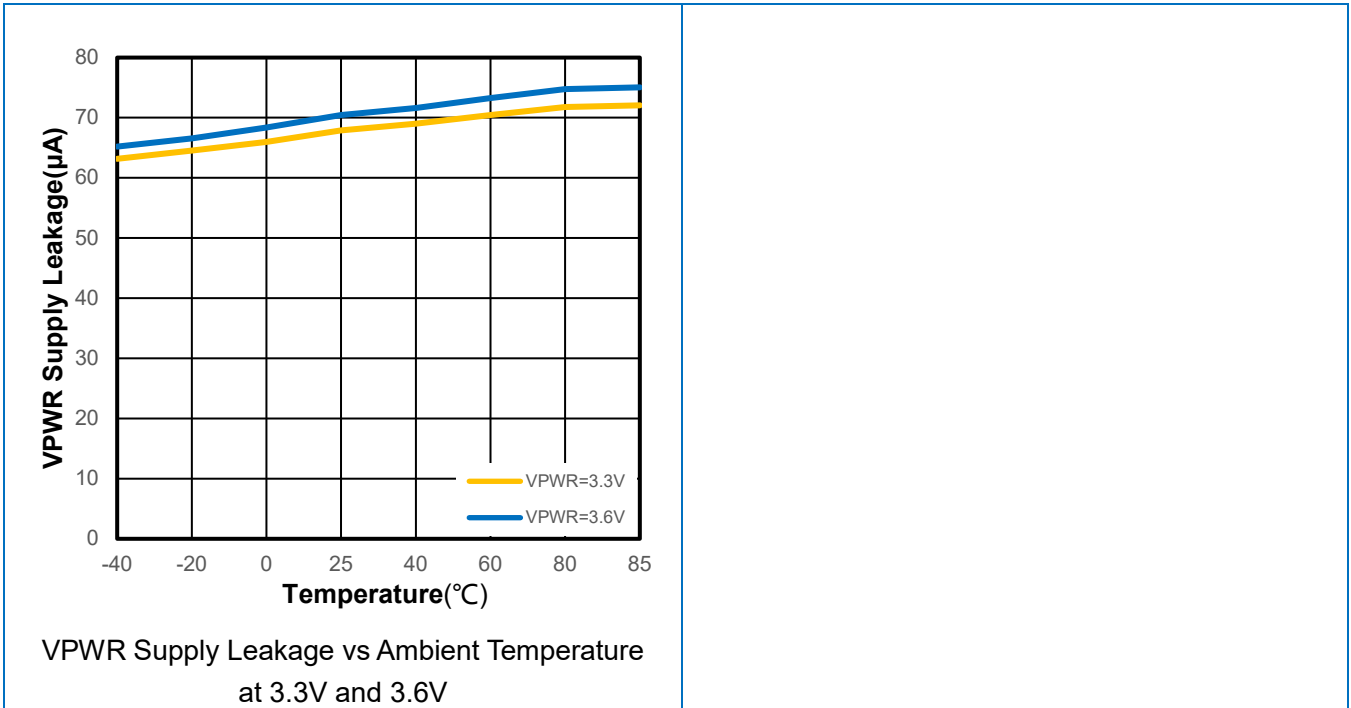C_SBU OVP Leakage Current vs Ambient Temperature at 5.5 V and 24 V
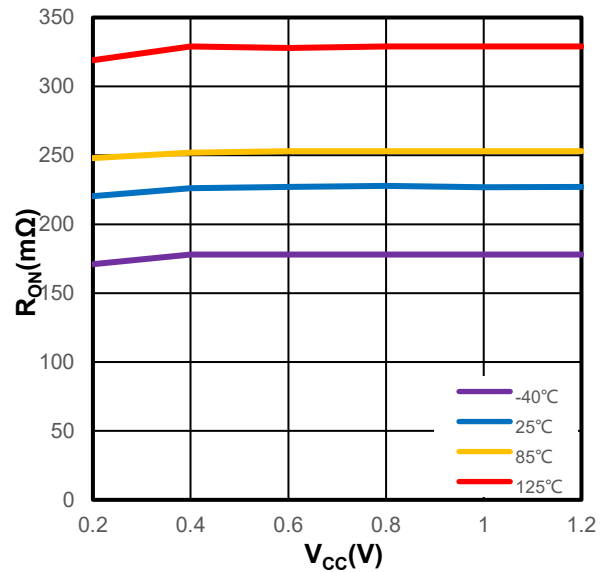

CC RON Flatness


C_CC Path Leakage Current vs Ambient Temperature at C_CC = 5.5 V


C_CC Path Leakage Current vs Ambient Temperature at C_CC = 24 V

VPWR Supply Leakage vs Ambient Temperature at 3.3V and 3.6V

# ● 11. Function Description

## ● 11.1 Overview

The WP5401 is a USB Type-C port protection chip that integrates four channels of 20-V Short-to-VBUS overvoltage protection for the CC1, CC2, SBU1, and SBU2 pins and six channels of IEC61000-4-2 ESD protection for the CC1, CC2, SBU1, SBU2, pins of the USB Type-C connector.

## 11.2 Block Diagram
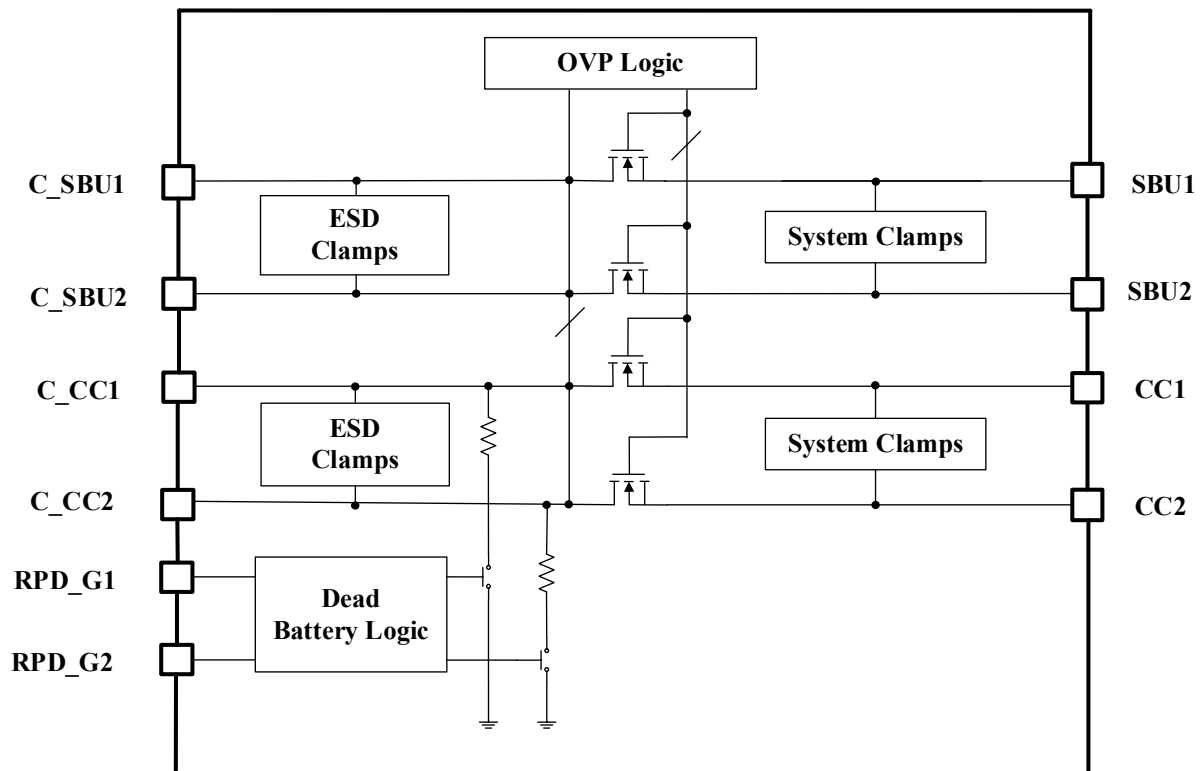


## ● 11.3 Feature Description

## ● 11.3.1 4-Channels of Short-to-VBUS Overvoltage Protection (CC1, CC2, SBU1, SBU2 Pins): 24-$V_{DC}$ Tolerant

The WP5401 provides 4-channels of Short-to-VBUS Overvoltage Protection for the CC1, CC2, SBU1, and SBU2 pins of the USB Type-C connector. The WP5401 is able to handle 24-VDC on its C_CC1, C_CC2, C_SBU1, and C_SBU2 pins. This is necessary because according to the USB PD specification, with VBUS set for 20-V operation, the VBUS voltage is allowed to legally swing up to 21 V, and 21.5 V on voltage transitions from a different USB PD VBUS voltage.

## ● 11.3.2 4-Channels of IEC 61000-4-2 ESD Protection (CC1, CC2, SBU1, SBU2 Pins)

The WP5401 integrates 4-Channels of IEC 61000-4-2 system level ESD protection for the CC1, CC2, SBU1, SBU2 pins.

USB Type-C ports on end-products need system level IEC ESD protection in order to provide adequate protection for the ESD events that the connector can be exposed to from end users.

● **11.3.3 Thermal Shutdown**

Thermal shutdown protects the part from internally or externally generated excessive temperatures. During an overtemperature condition the switch is turned off. The switch automatically turns on again if the temperature of the die drops below the threshold temperature.

● **11.3.4 Dead-battery Mode**

The WP5401 integrates high voltage dead battery RD pull-down resistors to allow dead battery charging simultaneously with high-voltage OVP protection. If dead battery support is required, short the RPD_G1 pin to the C_CC1 pin, and short the RPD_G2 pin to the C_CC2 pin. This connects the dead battery resistors to the connector CC pins.

● **12. Layout**

For best performance, place the bypass capacitors as close as possible to the VPWR pin, and ESD protection capacitor as close as possible to the $V_{BIAS}$ pin. The USB2.0 and SBU lines must be routed as straight as possible and any sharp bends must be minimized.

● **12.1 Layout Example**
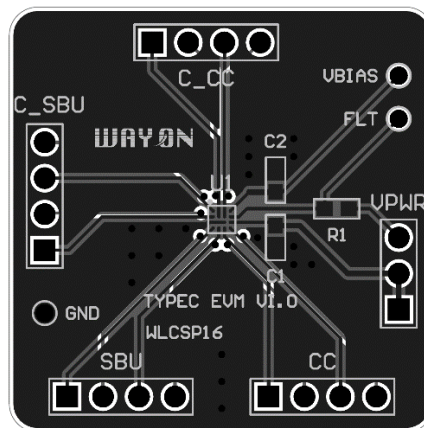


● **13 Evaluation Modules**

Evaluation Modules (EVMs) are available to help evaluate initial circuit performance. We have evaluation modules for different packages, you can contact us by phone or address at the end to get the evaluation module or schematic.

The module names are listed in the table below.

| NAME | PACKAGE | EVALUATION MODULE |
|---|---|---|
| WP5401 | WLCSP16 | TYPEC EVM V1.0 WLCSP16 |

- **14 Naming Conventions**

**WP AB CC-DDD E**

**WP:** WAYON Protection IC;

**A:** Product Category –5: Type C Protection;
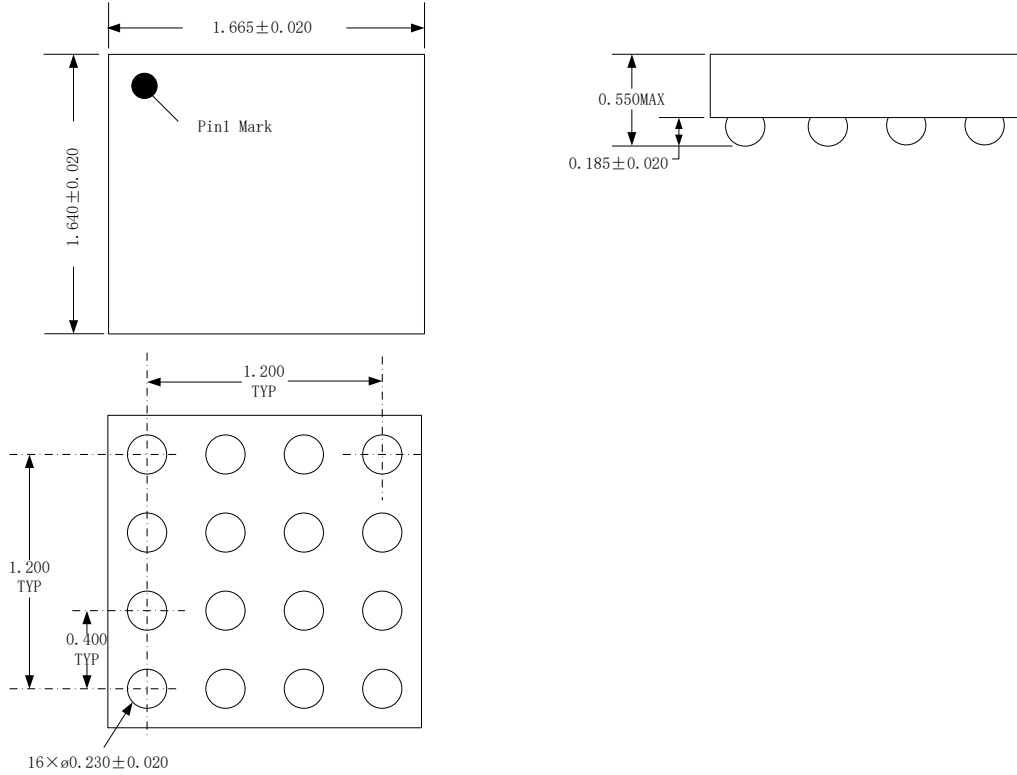
**B:** Number of Protection Channels – 4: 4 Channels;

**CC:** Serial Number;

**DDD:** Package – C16: WLCSP 16；

**E:** R-Reel & T-tube;

## ● 15 Package Information

**WLCSP 16**



1.665±0.020

1.640±0.020

Pin1 Mark

0.550MAX

0.185±0.020

1.200
TYP

1.200
TYP

0.400
TYP

16×ø0.230±0.020

● **16 Ordering Information**

| PART NUMBER | PACKAGE | PACKING QUANTITY | MARKING* |
| --- | --- | --- | --- |
| WP5401-C16R | WLCSP 16 | 3k/Reel | WP5401 XXXX |

**Contact Information**

No.1001, Shiwan(7) Road, Pudong District, Shanghai, P.R.China.201202

Tel: 86-21-68960674 Fax: 86-21-50757680 Email: market@way-on.com

WAYON website: http://www.way-on.com

For additional information, please contact your local Sales Representative.

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*Specifications are subject to change without notice.*

*The device characteristics and parameters in this data sheet can and do vary in different applications and actual device performance may vary over time.*

*Users should verify actual device performance in their specific applications.*

单击下面可查看定价，库存，交付和生命周期等信息

>>WAY-ON(维安)